



## General Description

The SJG20NP400 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a wide variety of applications.

## Features

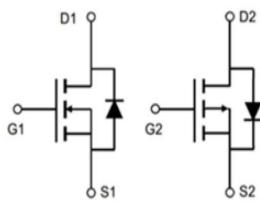
- Low Gate Charge
- High Power and current handing capability
- Lead free product is acquired

## Application

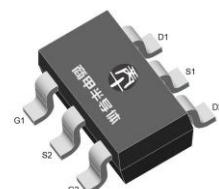
- PWM Applications
- Load Switch
- Power Management

## Key Performance Parametes

Parameter	Value	Value	Unit
$V_{DS}$	20	-20	V
$R_{DS(ON)}_{TYP}$	10.2	26.7	mΩ
$I_D$	8.2	-5.1	A
$Q_G$	8.5	8	nC



Schematic Diagram



SOT23-6L top view



## Package Marking and Ordering Information

Device/Ordering Code	Marking	Package	Packing	Reel Size	Tape width	Quantity
SJG20NP400	G20NP400	SOT23-6L	Tape	\	\	3000 Pcs

Table 1. Absolute Maximum Ratings ( $T_A=25^\circ\text{C}$  unless otherwise noted)

Symbol	Parameter	N Limit	P Limit	Unit
$V_{DS}$	Drain-Source Voltage ( $V_{GS}=0\text{V}$ )	20	-20	V
$V_{GS}$	Gate-Source Voltage ( $V_{DS}=0\text{V}$ )	$\pm 12$	$\pm 12$	V
$I_D$	Drain Current-Continuous( $T_A=25^\circ\text{C}$ )	8.2	-5.1	A
	Drain Current-Continuous( $T_A=100^\circ\text{C}$ )	5.2	-3.2	A
$I_{DM}$ (pulse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	32.8	-20.4	A
$P_D$	Maximum Power Dissipation( $T_A=25^\circ\text{C}$ )	1.25	1.25	W
	Maximum Power Dissipation( $T_A=100^\circ\text{C}$ )	0.5	0.5	W
$E_{AS}$	Avalanche energy (Note 2)	30	25	mJ
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	-55 To 150		°C

Table 2. Thermal Characteristic

Symbol	Parameter	N Limit	P Limit	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to- Ambient	100	100	°C/W



## 20V NP-Channel Trench Power MOSFET

Table 3. N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

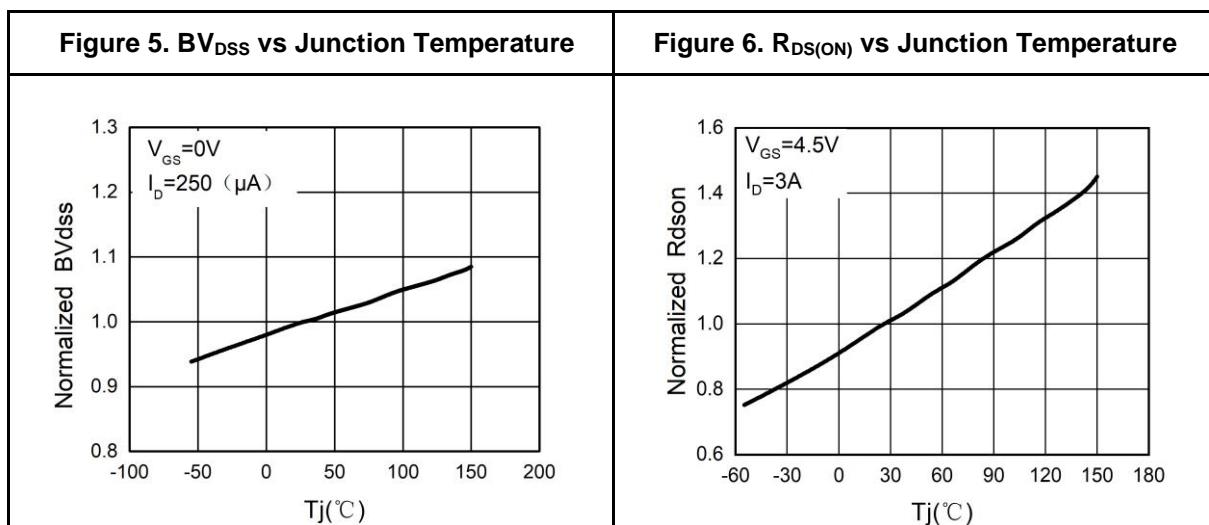
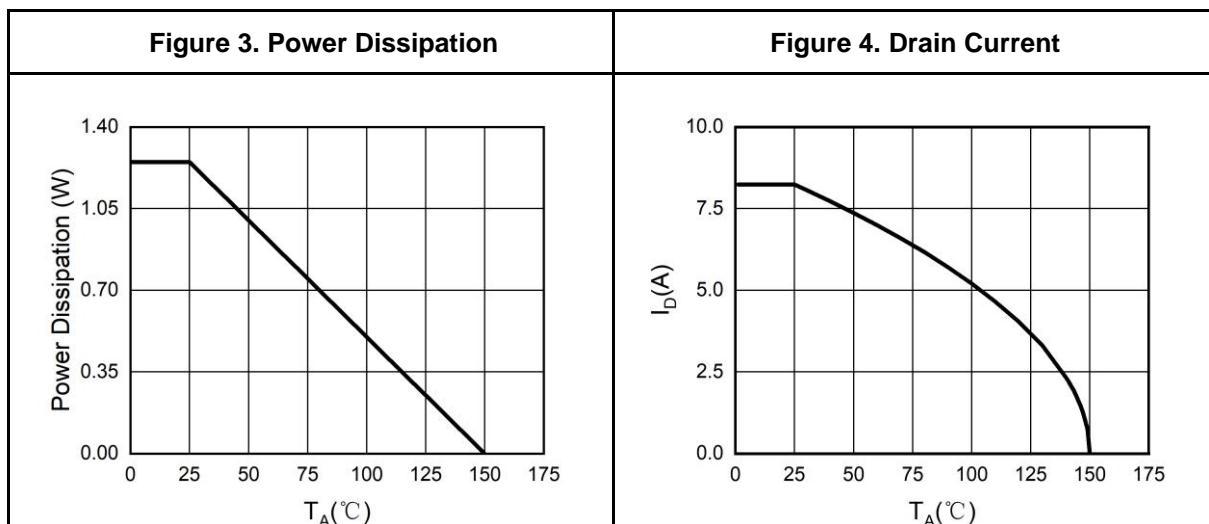
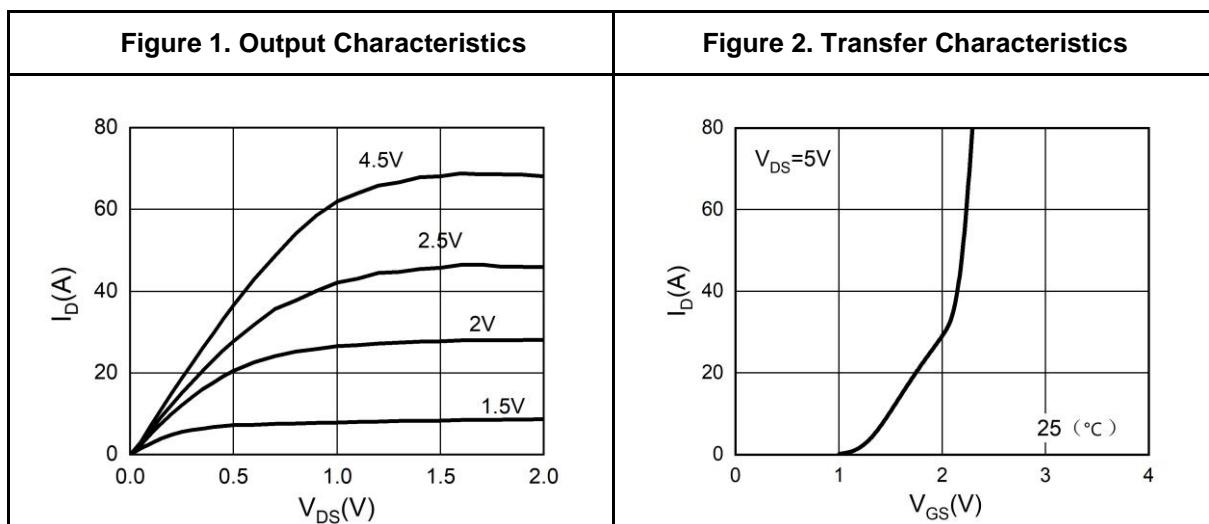
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>On/Off States</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_{\text{D}}=-250\mu\text{A}$	20			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=20\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=25^\circ\text{C}$			1	$\mu\text{A}$
		$V_{\text{DS}}=20\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $T_J=125^\circ\text{C}$			100	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 12\text{V}$ , $V_{\text{DS}}=0\text{V}$			$\pm 100$	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$ , $I_{\text{D}}=250\mu\text{A}$	0.4		1	V
$g_{\text{FS}}$	Forward Transconductance	$V_{\text{DS}}=5\text{V}$ , $I_{\text{D}}=3\text{A}$		13		S
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=4.5\text{V}$ , $I_{\text{D}}=3\text{A}$ , $T_J=25^\circ\text{C}$		10.2	12.8	$\text{m}\Omega$
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=2.5\text{V}$ , $I_{\text{D}}=2\text{A}$ , $T_J=25^\circ\text{C}$		16.3	21.7	$\text{m}\Omega$
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=10\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1.0\text{MHz}$		805		pF
$C_{\text{oss}}$	Output Capacitance			88		pF
$C_{\text{rss}}$	Reverse Transfer Capacitance			75		pF
$R_g$	Gate resistance	$V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=0\text{V}$ , $f=1.0\text{MHz}$		1.4		$\Omega$
<b>Switching Parameters</b>						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{GS}}=4.5\text{V}$ , $V_{\text{DS}}=10\text{V}$ , $R_L=3.3\Omega$ , $R_{\text{GEN}}=3\Omega$		6		nS
$t_r$	Turn-on Rise Time			20		nS
$t_{\text{d(off)}}$	Turn-Off Delay Time			28		nS
$t_f$	Turn-Off Fall Time			9		nS
$Q_g$	Total Gate Charge	$V_{\text{GS}}=4.5\text{V}$ , $V_{\text{DS}}=10\text{V}$ , $I_{\text{D}}=3\text{A}$		8.5		nC
$Q_{\text{gs}}$	Gate-Source Charge			1.4		nC
$Q_{\text{gd}}$	Gate-Drain Charge			1.5		nC
<b>Source-Drain Diode Characteristics</b>						
$I_{\text{SD}}$	Source-Drain Current (Body Diode)				8.2	A
$V_{\text{SD}}$	Forward on Voltage (Note 3)	$V_{\text{GS}}=0\text{V}$ , $I_{\text{S}}=4\text{A}$			1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$I_F=3\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$		4.3		ns
$Q_{\text{rr}}$	Reverse Recovery Charge	$I_F=3\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$		0.6		nC

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

Notes 2.E<sub>AS</sub> condition:  $T_J=25^\circ\text{C}$ ,  $V_{\text{DD}}=20\text{V}$ ,  $V_G=10\text{V}$ ,  $R_g=25\Omega$ ,  $L=0.5\text{mH}$ .

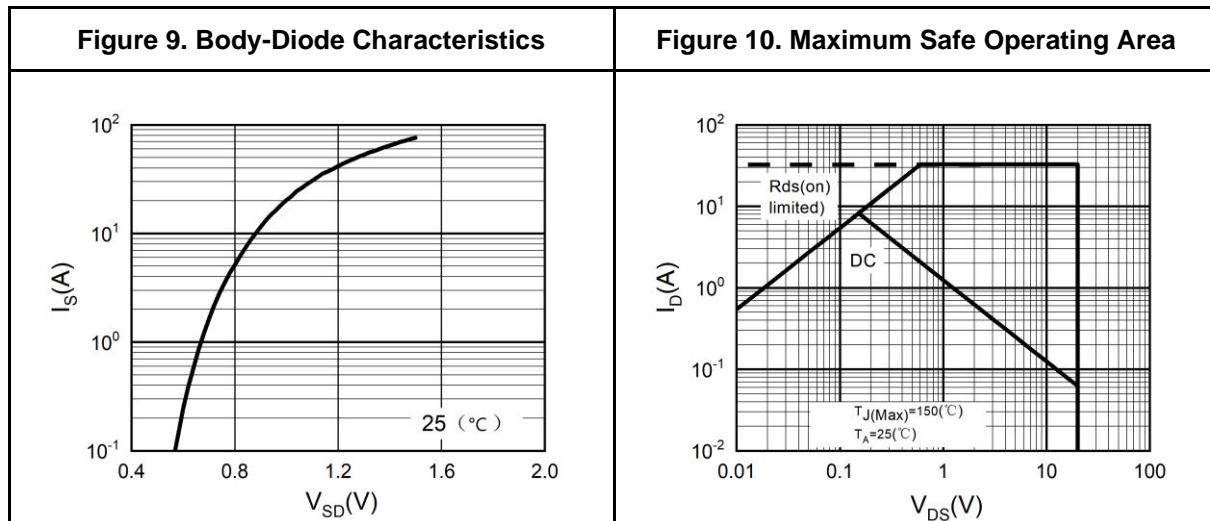
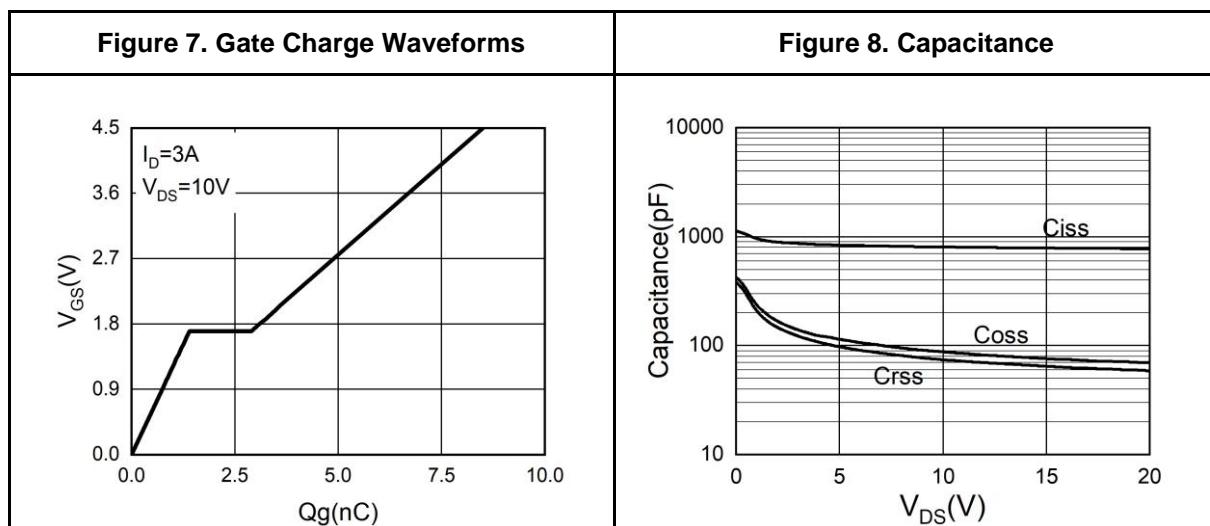
Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.

## N-Channel Typical Electrical And Thermal Characteristics (Curves)





## N-Channel Typical Electrical And Thermal Characteristics (Curves)





## 20V NP-Channel Trench Power MOSFET

Table 4. P-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

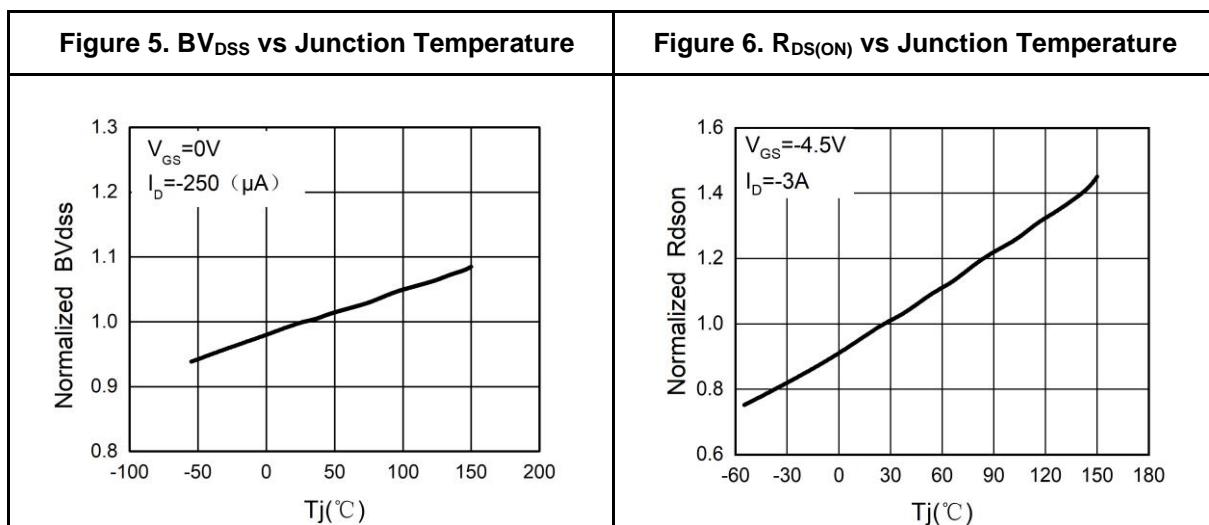
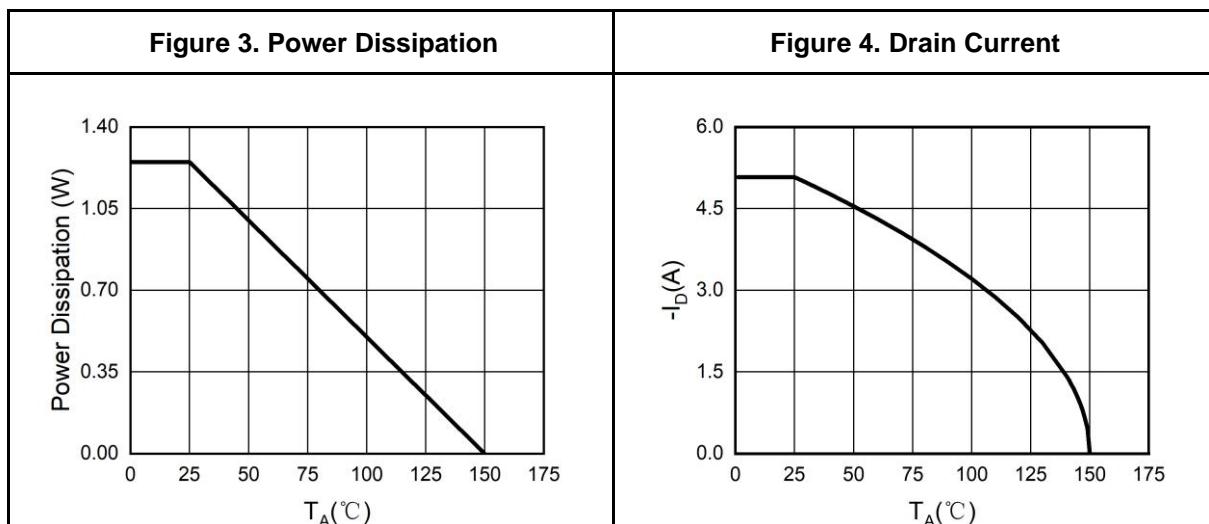
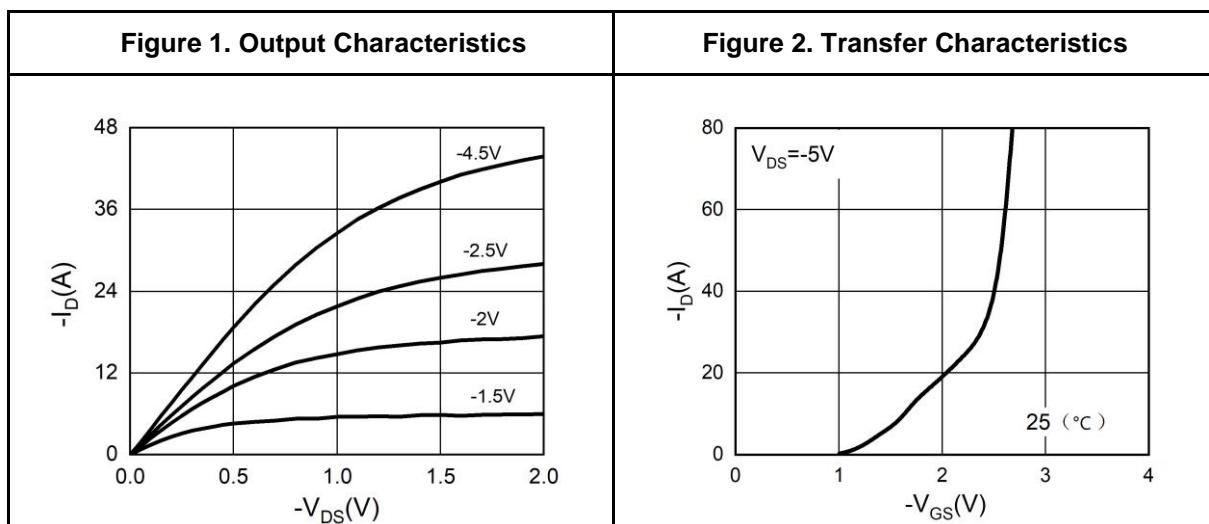
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>On/Off States</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ $I_{\text{D}}=-250\mu\text{A}$	-20			V
$I_{\text{DSS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-20\text{V}$ , $V_{\text{GS}}=0\text{V}$ $T_J=25^\circ\text{C}$			-1	$\mu\text{A}$
		$V_{\text{DS}}=-20\text{V}$ , $V_{\text{GS}}=0\text{V}$ $T_J=125^\circ\text{C}$			-100	$\mu\text{A}$
$I_{\text{GSS}}$	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 12\text{V}$ , $V_{\text{DS}}=0\text{V}$			$\pm 100$	nA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$ , $I_{\text{D}}=-250\mu\text{A}$	-0.5		-1	V
$g_{\text{FS}}$	Forward Transconductance	$V_{\text{DS}}=-5\text{V}$ , $I_{\text{D}}=-3\text{A}$		11		S
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=-4.5\text{V}$ , $I_{\text{D}}=-3\text{A}$ $T_J=25^\circ\text{C}$		26.7	33.4	$\text{m}\Omega$
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance	$V_{\text{GS}}=-2.5\text{V}$ , $I_{\text{D}}=-2\text{A}$ $T_J=25^\circ\text{C}$		37	49.2	$\text{m}\Omega$
<b>Dynamic Characteristics</b>						
$C_{\text{iss}}$	Input Capacitance	$V_{\text{DS}}=-10\text{V}$ , $V_{\text{GS}}=0\text{V}$ , $f=1.0\text{MHz}$		872		pF
$C_{\text{oss}}$	Output Capacitance			103		pF
$C_{\text{rss}}$	Reverse Transfer Capacitance			87		pF
$R_g$	Gate resistance	$V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=0\text{V}$ , $f=1.0\text{MHz}$		6		$\Omega$
<b>Switching Parameters</b>						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{GS}}=-4.5\text{V}$ , $V_{\text{DS}}=-10\text{V}$ , $R_L=3.3\Omega$ , $R_{\text{GEN}}=3\Omega$		26		nS
$t_r$	Turn-on Rise Time			45		nS
$t_{\text{d(off)}}$	Turn-Off Delay Time			70		nS
$t_f$	Turn-Off Fall Time			58		nS
$Q_g$	Total Gate Charge	$V_{\text{GS}}=-4.5\text{V}$ , $V_{\text{DS}}=-1\text{V}$ , $I_{\text{D}}=-3\text{A}$		8		nC
$Q_{\text{gs}}$	Gate-Source Charge			1.4		nC
$Q_{\text{gd}}$	Gate-Drain Charge			1.6		nC
<b>Source-Drain Diode Characteristics</b>						
$I_{\text{SD}}$	Source-Drain Current (Body Diode)				-5.1	A
$V_{\text{SD}}$	Forward on Voltage (Note 3)	$V_{\text{GS}}=0\text{V}$ , $I_{\text{S}}=-5\text{A}$			-1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$I_F=-3\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$		17		ns
$Q_{\text{rr}}$	Reverse Recovery Charge	$I_F=-3\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$		7		nC

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

Notes 2.EAS condition:  $T_J=25^\circ\text{C}$ ,  $V_{\text{DD}}=-20\text{V}$ ,  $V_{\text{G}}=-10\text{V}$ ,  $R_g=25\Omega$ ,  $L=0.5\text{mH}$ .

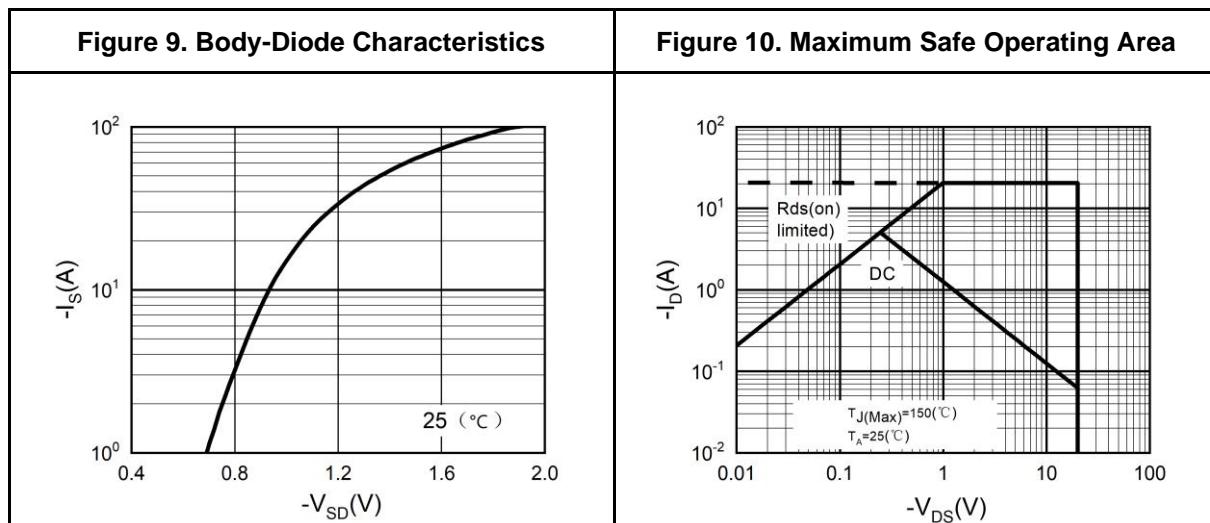
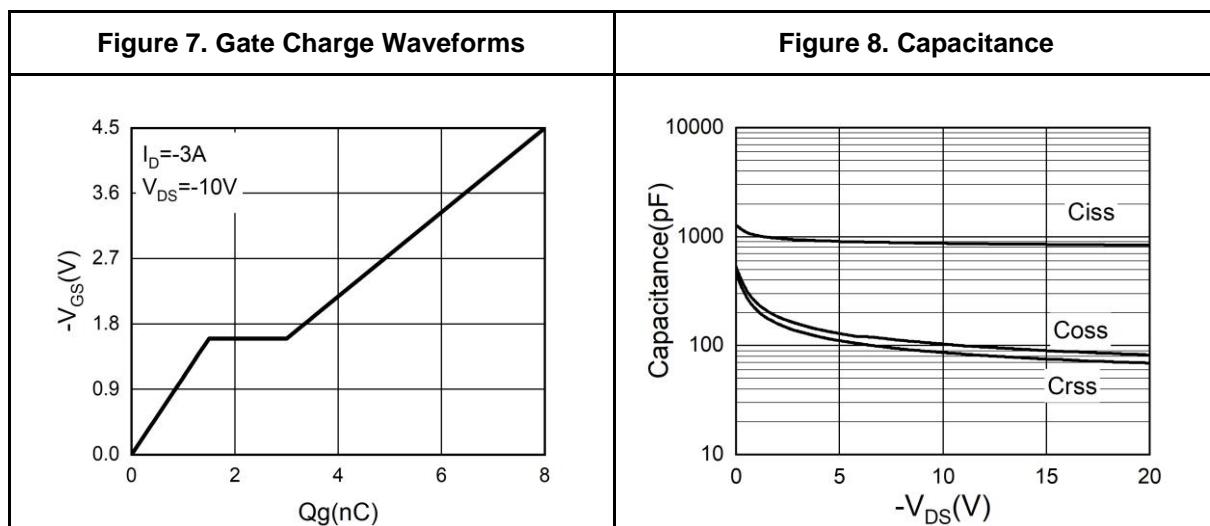
Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.

## P-Channel Typical Electrical And Thermal Characteristics (Curves)



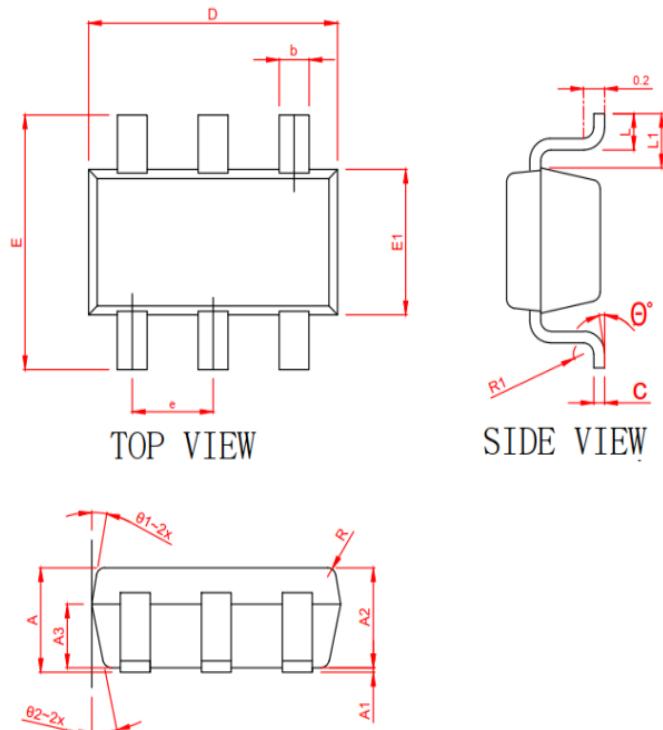


## P-Channel Typical Electrical And Thermal Characteristics (Curves)





SOT23-6L Package Information



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	1.06	1.15	1.24
* A1	0.01	0.05	0.09
* A2	1.05	1.10	1.15
A3	0.65	0.70	0.75
* b	0.30	0.35	0.45
* c	0.127REF		
* D	2.87	2.92	2.97
* E	2.72	2.80	2.88
* E1	1.55	1.60	1.65
* e	0.95BSC		
* L	0.32	0.40	0.48
* L1	0.55	0.60	0.65
R	0.10 REF		
R1	0.12 REF		
* θ	0	--	8°
θ1	8°	10°	12°
θ2	10°	12°	14°



## Attention

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi Shangjia Semiconductor.

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